

Search Notes

Application/Control No.

10/724,771

Examiner

Justin Krause

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

3682

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|--|-----------|----------|
| 384 | 100 107 113 114 115 118 119 120 286 322 | 12/5/2005 | JMK |
| 384 | 397 | | |
| 360 | 99.08 | | |
| 417 | 354 423.12 | | |
| 417 | 423.13 | | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-----------------------|-----------|------|
| See EAST history | 12/5/2005 | JMK |
| PLUS search | | |
| Search from T. Hannon | | |
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